

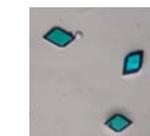


# Single Crystal Diffraction

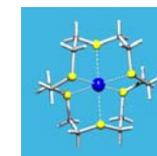
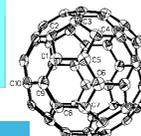
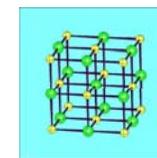
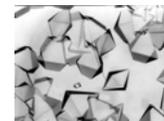
Cheiron School, Spring8, 2012  
Claire Wilson



## Our aim



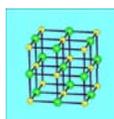
Xray diffraction



- To explore getting from a crystal to a structural model

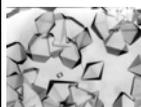
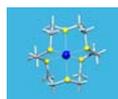


## Single Crystals

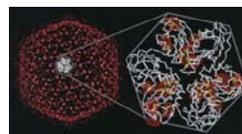


Material in solid state with 3-d translational symmetry

- Crystals may be:
  - elements (e.g. diamond), minerals, inorganic salts, molecular materials (organic, metal complexes), extended lattice structures (MOFs), macromolecules (proteins, DNA, viruses)

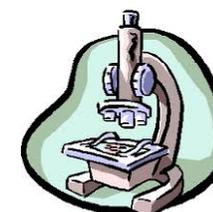
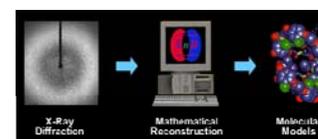


For synchrotron single crystal diffraction experiments crystals are typically 10 – 100 microns in size ( $1\mu\text{m} = 1 \times 10^{-6}\text{m} = 10,000\text{\AA}$ )

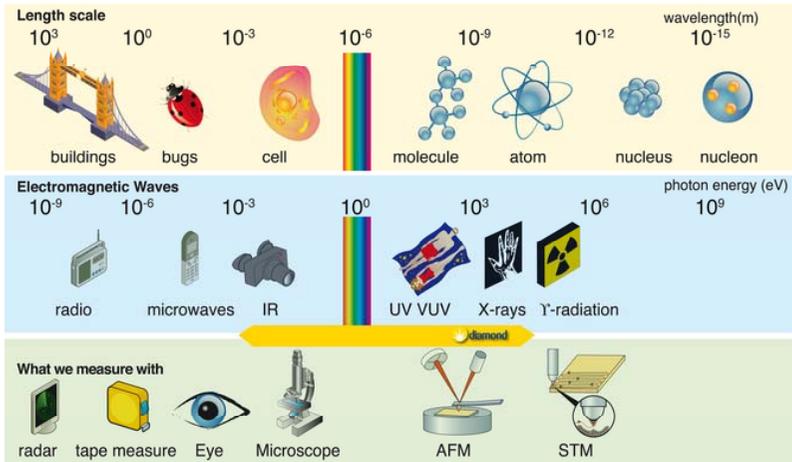


## Microscope analogy

- With visible light look at objects similar size to wavelength (400-700nm)
- For atoms and molecules radiation with wavelength of similar size is xrays
- Reform image mathematically and not in real time

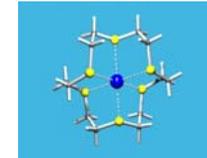
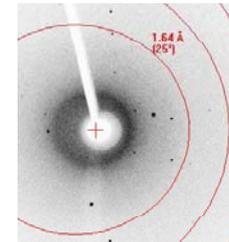


## The many colours of light



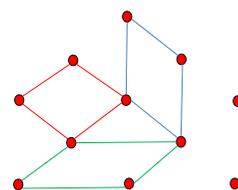
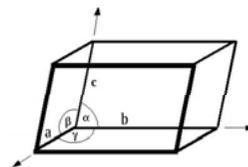
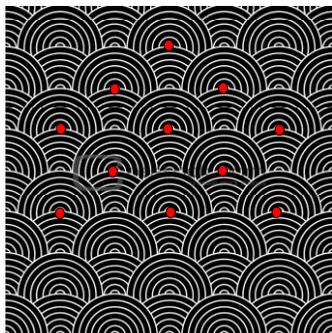
## Why do we need a crystal?

- Identical repeat unit repeated infinitely in 3 dimensions leads to diffraction
- Measure position and intensity of diffracted beams and work back to the structure

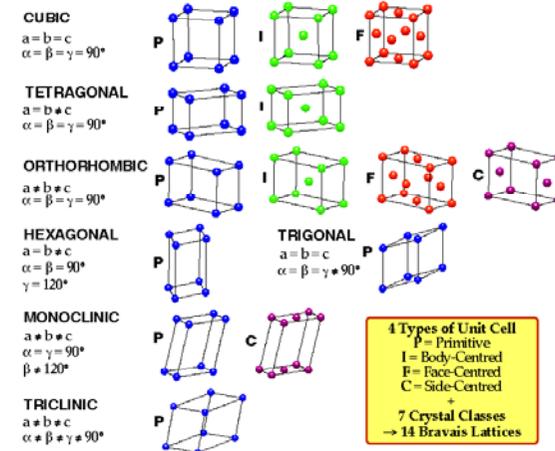


## Lattice

- Array of points equivalent by translation – lattice
- Unit cell describes geometry of lattice



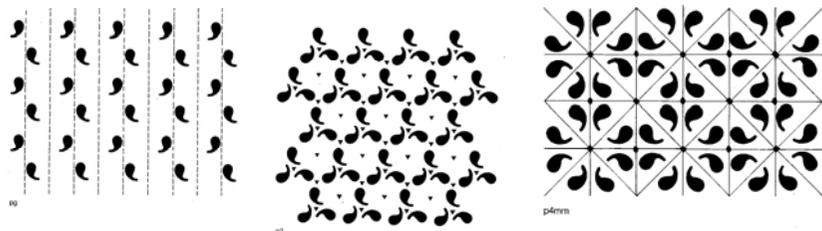
## Crystal Systems



# Symmetry

## Definition

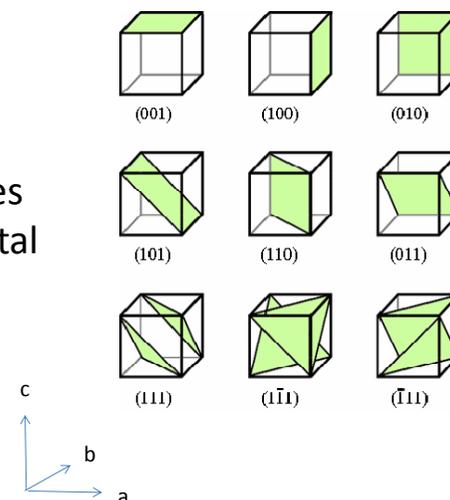
– A **crystallographic symmetry operation** is a symmetry operation, which maps a (periodic) crystal structure onto itself.



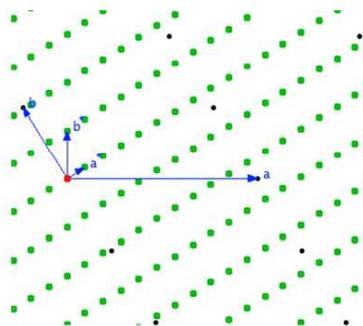
<http://www.york.ac.uk/depts/math/histstat/symmetry/welcome.htm>

# Miller indices hkl

- Description of orientation of planes slicing through crystal



# Reciprocal lattice



- Valuable construct in diffraction
- Reciprocal geometric relationship between crystal lattice and its diffraction pattern

<http://escher.epfl.ch/rlattice/>

# Reciprocal lattice relationships

- $\mathbf{a}^* \cdot \mathbf{b} = \mathbf{a}^* \cdot \mathbf{c} = \mathbf{b}^* \cdot \mathbf{a} = \mathbf{b}^* \cdot \mathbf{c} = \mathbf{c}^* \cdot \mathbf{a} = \mathbf{c}^* \cdot \mathbf{b} = 0$
- $\mathbf{a}^* \cdot \mathbf{a} = \mathbf{b}^* \cdot \mathbf{b} = \mathbf{c}^* \cdot \mathbf{c} = 1$
- $\mathbf{a}^* = (\mathbf{b} \times \mathbf{c}) / V(4)$
- $\mathbf{b}^* = (\mathbf{c} \times \mathbf{a}) / V(5)$
- $\mathbf{c}^* = (\mathbf{a} \times \mathbf{b}) / V(6)$
- $V^* = \mathbf{a} \cdot \mathbf{b} \times \mathbf{c}$

Reciprocal lattice vector

$$\mathbf{h} = h\mathbf{a}^* + k\mathbf{b}^* + l\mathbf{c}^*$$

$$\mathbf{a} \times \mathbf{b} = |\mathbf{a}| |\mathbf{b}| \sin\theta \mathbf{a} \cdot \mathbf{b} = |\mathbf{a}| |\mathbf{b}| \cos\theta$$

## Diffraction

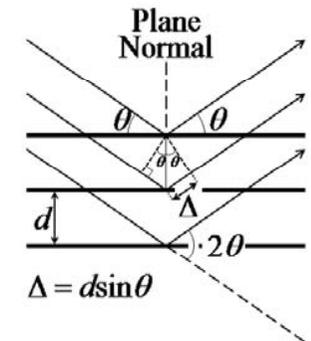
- Radiation scattered in all directions
- only measurable intensity where constructive interference – scattered waves are in phase
- xrays scattered by different points must have path length differences equal to  $n\lambda$
- Laue Conditions – 3 conditions in 3D must be simultaneously satisfied to have diffraction

## The Bragg Equation

- Consider diffraction as if reflection from sets of planes passing through lattice points
- Path length difference of the scattered rays from adjacent planes is  $2\Delta$

$$n\lambda = 2d_{hkl} \sin\theta$$

Usually ignore n and consider  $n=2$  as scattering from planes  $2h, 2k, 2l$



## Scattering vector

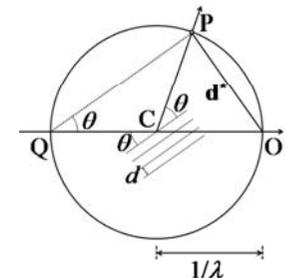
- In plane of and bisecting the incident and diffracted beams with magnitude  $1/d$  or  $d^*$
- Rearrange Bragg equation

$$\sin\theta = (\lambda/2) (1/d)$$

scattering angle related to  $1/d$

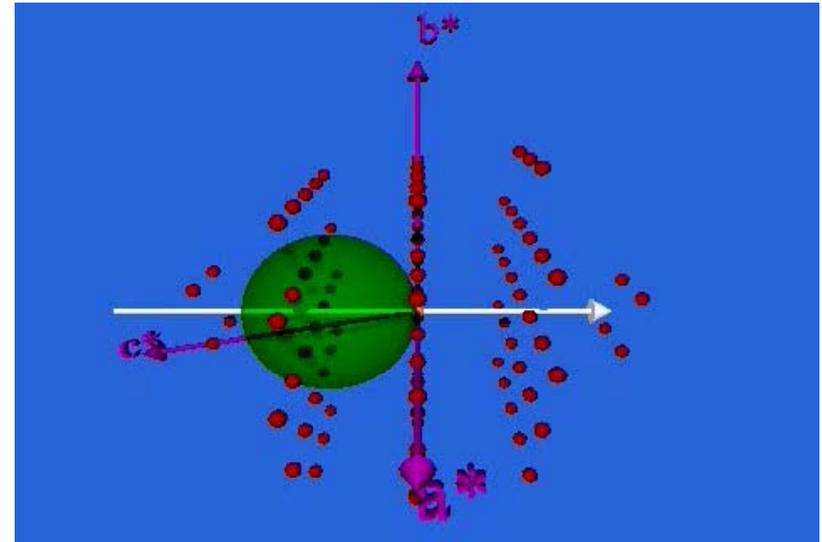
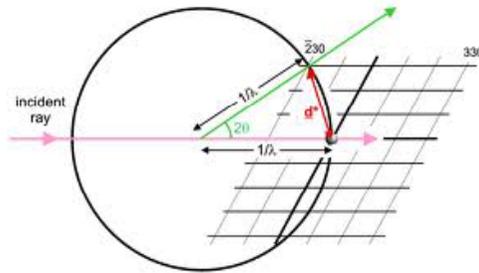
## Ewald sphere

- For monochromatic beam - sphere radius  $1/\lambda$  centered on crystal (C)
- Incident beam enters at Q
- Origin of reciprocal space at O
- Bragg equation is satisfied when node P on surface of sphere the  $\sin\theta = OP/QO = d^*/(2/\lambda) = \lambda/2d$



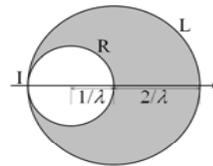
## Ewald sphere

- Crystal rotated to bring reciprocal lattice points into diffracting position
- Multiple diffraction
- Lorentz Factor
- Blind regions



## Limiting Sphere

- Boundary between observable and unobservable reflections for a given wavelength,  $\lambda$
- Long wavelengths – small limiting sphere – lower resolution data obtainable



L is the limiting sphere radius  $2/\lambda$ ,  
R the reflecting sphere radius  $1/\lambda$ .

## Intensity of Diffracted beams

- Lattices and unit cells describe geometry of diffraction
- Diffracted intensities differ for different reflections – depend on orientation of plane in crystal
- Weak and strong intensities – both contain information
- Weaker at high scattering angles – atomic scattering factor and temperature factor
- Depend on unit cell contents – atom types and positions
- $I(\mathbf{h}) = k |F(\mathbf{h})|^2$

## Structure factor $F(\mathbf{h})$

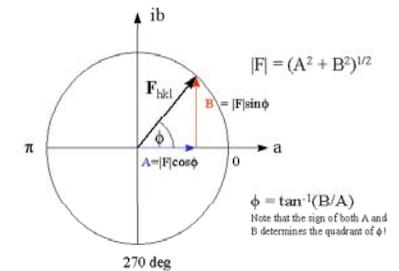
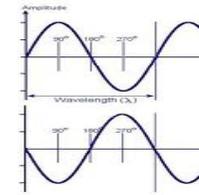
$$F(\mathbf{h}) = \sum_{j=1}^n f_j e^{2\pi i \mathbf{h} \cdot \mathbf{x}_j} = |F(\mathbf{h})| e^{i\phi(\mathbf{h})}$$

- Structure factor for a given plane or reflection ( $\mathbf{h}$ )
- Summed over all  $j$  atoms in unit cell, with positions  $\mathbf{x}_j$  and that have scattering power  $f_j$  – atomic scattering factor
- $\mathbf{x}_j = x_j \mathbf{a} + y_j \mathbf{b} + z_j \mathbf{c}$  position of atom  $j$
- $\mathbf{h} = h\mathbf{a}^* + k\mathbf{b}^* + l\mathbf{c}^*$
- $\mathbf{h} \cdot \mathbf{x}_j = hx_j + ky_j + lz_j$

## Structure factor representation

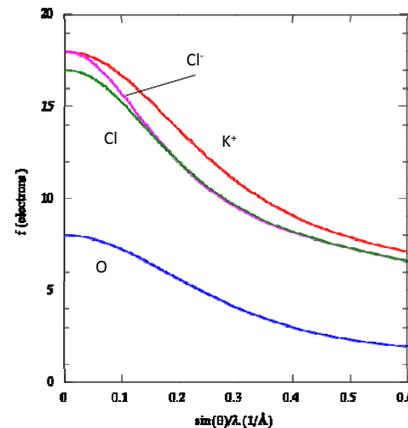
$$F(\mathbf{h}) = |F(\mathbf{h})| e^{i\phi(\mathbf{h})} = A(\mathbf{h}) + iB(\mathbf{h}) = |F(\mathbf{h})| (\cos \phi(\mathbf{h}) + i \sin \phi(\mathbf{h}))$$

- Each reflection (diffracted wave) has amplitude  $|F|$  and phase  $\phi$

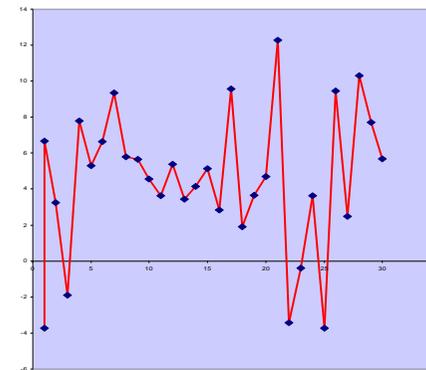


## Xray atomic scattering factors

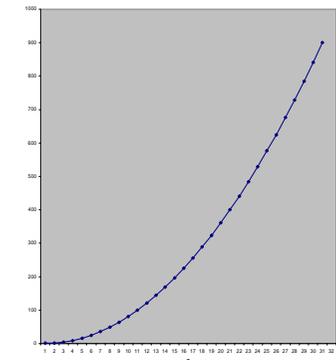
- Not point scatterer – electron cloud
- $2\theta=0^\circ$  electrons scatter in phase = atomic number



## Neutron scattering



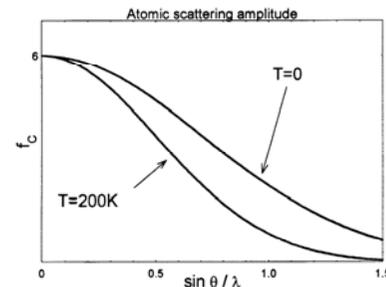
Neutron scattering length (fm) – random variation with  $Z$



scattered intensity for X-rays – proportional to  $Z^2$

## Atomic scattering factors and atomic displacements

- Atoms in crystals not stationary but vibrating
- Intensity reduced at higher T and higher angles by temperature or Debye-Waller factor, B
- U, mean displacement of atom



$$f_B = f \cdot e^{-B(\sin \theta / \lambda)^2}$$

$$B = 8\pi^2 \langle u^2 \rangle$$

## Structure factor

$$F(\mathbf{h}) = \int_{\text{cell}} \rho(\mathbf{x}) d\mathbf{x} e^{2\pi i \mathbf{h}\mathbf{x}} = \sum_{j=1}^n f_j e^{2\pi i \mathbf{h}\mathbf{x}_j}$$

- $F(\mathbf{h})$  integrated electron density  $\rho$  at every point  $\mathbf{x}$  in the unit cell
- Or summation atomic scattering factors  $f_j$  (all  $j$  atoms in unit cell)
- Structure factor (phase and amplitude) - Fourier transform of the electron density

## Electron density

$$\rho(\mathbf{x}) = \frac{1}{V} \sum_{\mathbf{h}} F(\mathbf{h}) e^{-2\pi i \mathbf{h}\mathbf{x}}$$

$V$  = unit cell volume

- $\rho(\mathbf{x})$  inverse Fourier transform of  $F(\mathbf{h})$
- With all  $F(\mathbf{h})$  (phase and amplitude) - complete description of unit cell contents

## The 'Phase problem'

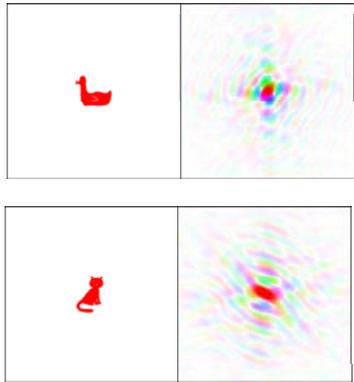
$$\rho(\mathbf{x}) = \frac{1}{V} \sum_{\mathbf{h}} F(\mathbf{h}) e^{-2\pi i \mathbf{h}\mathbf{x}}$$

But do not have all information to reconstruct  $\rho(\mathbf{x})$

$$F(\mathbf{h}) = \sum_{j=1}^n f_j e^{2\pi i \mathbf{h}\mathbf{x}_j} = |F(\mathbf{h})| e^{i\phi(\mathbf{h})}$$

- ✓  $V$  - unit cell volume
- ✓  $|F(\mathbf{h})|$  - structure factor amplitude (proportional to measured intensities)
- ✗  $\phi(\mathbf{h})$  - phase information - don't measure

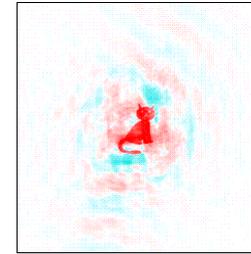
## Is the phase important?



A duck and its Fourier transform  
and a cat and its Fourier transform

From Kevin Cowtan's Book of Fourier  
<http://www.yybl.york.ac.uk/~cowtan/fourier/magic.html>

## Is the phase important?



- Take amplitudes (magnitudes) from duck transform with the phases from the cat transform and when you reconstruct an image it is recognisable as a cat
- The image that contributed to the magnitudes has gone

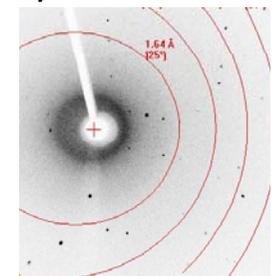
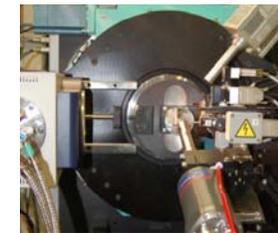
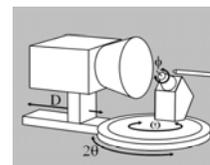
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## Is the phase important?

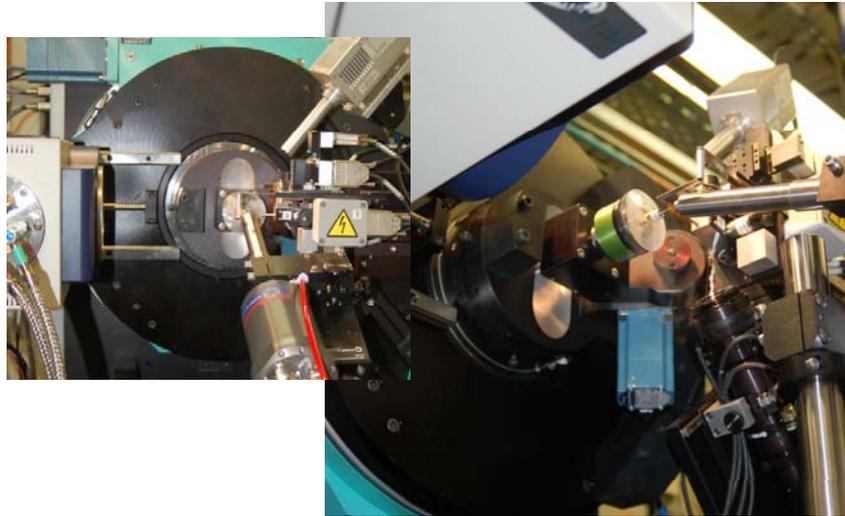
- The phase contains much more information about the atomic positions than the amplitudes
- Need some way to obtain estimated values for the phase and to 'solve' the structure

## Data collection

- Xray source
- Diffractometer – circles to move crystal
- Detectors - CCD, image plate, pixel detectors to measure position and intensity of diffracted intensities



## Diffractometer



<http://phillips-lab.biochem.wisc.edu/xrayviewuse.html>

## Experimental considerations

- Some examples of experimental choices:
  - choice of crystal
  - wavelength to use
  - sample environment e.g. temperature
  - exposure time
  - resolution of data
- Depending on material and nature of study

## Data reduction

- Convert measured intensities to  $|F_{\text{obs}}|$  - 'observed structure factor amplitudes' with associated standard uncertainty,  $\sigma(F_{\text{obs}})$
- Corrections applied e.g.
  - Lorenz-polarisation effects
  - Absorption correction – absorption by crystal depends on path length through crystal for a given reflection, unit cell contents, wavelength
- Unit cell parameters
- Space group determination
- Result – list of reflections as  $h, k, l, |F_{\text{obs}}|, \sigma(F_{\text{obs}})$

## Structure Solution methods

- Direct methods
  - Heavy-atom (Patterson) methods
  - Charge flipping
    - Fragment searches
    - Inference
    - isostructural relationships
- Result may be one heavy atom site or complete non-hydrogen structure depending on method and success level

## Model development

$$F(\mathbf{h}) = \sum_{j=1}^n f_j e^{2\pi i \mathbf{h} \cdot \mathbf{x}_j} = |F(\mathbf{h})| e^{i\phi(\mathbf{h})}$$

- Calculate amplitudes  $|F_{\text{calc}}(\mathbf{h})|$  and phases as now 'know' some atom positions  $\mathbf{x}_j$  from trial structure
- Fourier transform  $|F_{\text{obs}}(\mathbf{h})|$  with **calculated** phases – **new** information - model density plus additional atoms not included in model
- Difference Fourier maps using  $|F_{\text{obs}}(\mathbf{h})| - |F_{\text{calc}}(\mathbf{h})|$  missing atoms/misassigned atoms clearer

## Model development and structure refinement

- Include 'new' atoms in model and repeat until all atoms located
- Model improvements – displacement parameter modeling – isotropic-anisotropic, disorder, hydrogen atoms
- Least squares refinement - minimise  $|F_{\text{obs}}(\mathbf{h})| - |F_{\text{calc}}(\mathbf{h})|$  to give best fit of model

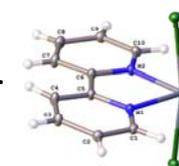
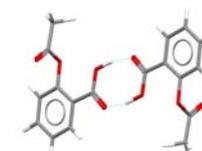
## Structure model

Typically consists of

- Atom type e.g. C, N, Fe (which atomic form factor to use)
- Atom positions in fractional coordinates  $x, y, z$
- Site occupancy
- Atomic displacement parameters – usually isotropic  $U_{\text{iso}}$  or anisotropic  $U_{ij}$
- Unit cell and space group

## Results and interpretation

- Result - electron density map
- Refined model
  - coordinates of atoms,  $x, y, z$  with estimated error, at centre of electron density peaks
  - Atomic displacement parameters
  - Unit cell parameters and space group
- Interpret - bond lengths and angles for 'bonded' atoms, torsion angles
- Intermolecular distances e.g. H-bonding.



## Web resources

- Kevin Cowtan  
<http://www.ysbl.york.ac.uk/~cowtan/>
- Gervais Chapuis  
<http://escher.epfl.ch/eCrystallography/>
- Xrayview <http://phillips-lab.biochem.wisc.edu/xrayviewuse.html>
- Joe Reibenspies  
<http://xray.tamu.edu/courses.php>